Application/Control No. Applicant(s)/Patent Under Reexamination 10/659,271 YAGUCHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 John L. Goodrow 1756 **U.S. PATENT DOCUMENTS Document Number** Date Name Country Code-Number-Kind Code MM-YYYY Classification US-Α US-В US-C US-D US-E US-F US-G US-Н US-US-US-K US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Country Code-Number-Kind Code MM-YYYY Name Classification 05 95-2002 JP 2002-129063 N Japan Toshiaki et al JP 07-064349 0 10-1995 Japan Satoshi et al P Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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